

CSD83325L 12V 双路 N 通道 NexFET™ 功率 MOSFET

1 特性

- 共漏极结构
- 低导通电阻
- 2.2mm × 1.15mm 小外形封装
- 无铅
- 符合 RoHS 环保标准
- 无卤素
- 栅极静电 (ESD) 保护

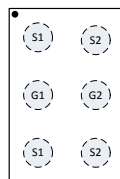
2 应用

- 电池管理
- 电池保护

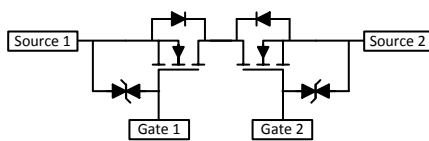
3 说明

此 12V、9.9mΩ、2.2mm × 1.15mm LGA 双路 NexFET™ 功率 MOSFET 旨在以小外形封装最大程度地降低电阻和栅极电荷。该器件的外形尺寸较小并采用共漏极配置，非常适合小型手持设备中由电池供电的应用。

俯视图



配置



产品概要

$T_A = 25^\circ\text{C}$		典型值	单位
V_{S1S2}	源极电压	12	V
Q_g	栅极电荷总量 (4.5V)	8.4	nC
Q_{gd}	栅极电荷 (栅极到漏极)	1.9	nC

产品概要 (接下页)

$T_A = 25^\circ\text{C}$		典型值		单位
$R_{S1S2(on)}$	源极至源极导通电阻	$V_{GS} = 2.5\text{V}$	17.5	mΩ
		$V_{GS} = 3.8\text{V}$	10.9	mΩ
		$V_{GS} = 4.5\text{V}$	9.9	mΩ
$V_{GS(th)}$	阈值电压	0.95		V

器件信息(1)

器件	数量	包装介质	封装	运输
CSD83325L	3000	7 英寸卷带	2.20mm × 1.15mm 接合栅格阵列 (LGA) 封装	卷带封装
CSD83325LT	250			

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

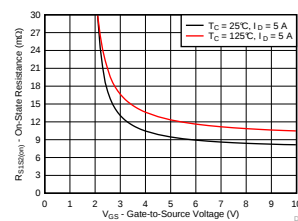
绝对最大额定值

$T_A = 25^\circ\text{C}$		值	单位
V_{S1S2}	源极电压	12	V
V_{GS}	栅极电压	±10	V
I_S	持续源极电流 ⁽¹⁾	8	A
I_{SM}	脉冲源极电流 ⁽²⁾	52	A
P_D	功率耗散	2.3	W
$V_{(ESD)}$	人体模型 (HBM)	2000	V
T_J, T_{stg}	工作结温, 储存温度	-55 至 150	°C

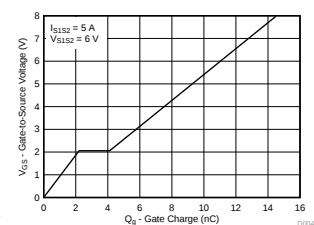
(1) 器件在 105°C 温度下运行。

(2) $R_{\theta JA} = 150^\circ\text{C/W}$ (覆铜面积最小时的典型值)，脉冲持续时间 $\leq 100\mu\text{s}$ ，占空比 $\leq 1\%$ 。

$R_{DS(on)}$ 与 V_{GS} 间的关系



栅极电荷



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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision A (January 2016) to Revision B	Page
• Added Diode Characteristics ($V_{F(S-S)}$) in the <i>Electrical Characteristics</i> table	3
• Added Figure 9 to <i>Typical MOSFET Characteristics</i> section	4
• 已添加 接收文档更新通知部分改为器件和文档支持部分	7

Changes from Original (November 2014) to Revision A	Page
• Improved graph setup for readability	4
• 已添加 社区资源	7

5 Specifications

5.1 Electrical Characteristics

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV _{S1S2}	Source-to-source voltage	V _{GS} = 0 V, I _S = 250 μA	12			V
I _{S1S2}	Source-to-source leakage current	V _{GS} = 0 V, V _{S1S2} = 9.6 V	1			μA
I _{GSS}	Gate-to-source leakage current	V _{S1S2} = 0 V, V _{GS} = 10 V	10			μA
V _{GS(th)}	Gate-to-source threshold voltage	V _{S1S2} = V _{GS} , I _S = 250 μA	0.75	0.95	1.25	V
R _{S1S2(on)}	Source-to-source on resistance	V _{GS} = 2.5 V, I _S = 5 A	14.0	17.5	23.0	mΩ
		V _{GS} = 3.8 V, I _S = 5 A	8.8	10.9	13.0	mΩ
		V _{GS} = 4.5 V, I _S = 5 A	7.9	9.9	11.9	mΩ
g _{fs}	Transconductance	V _{S1S2} = 1.2 V, I _S = 5 A	36			S
DYNAMIC CHARACTERISTICS ⁽¹⁾						
C _{iss}	Input capacitance	V _{GS} = 0 V, V _{S1S2} = 6 V, f = 1 MHz		902	1170	pF
C _{oss}	Output capacitance			187	243	pF
C _{rss}	Reverse transfer capacitance			111	144	pF
Q _g	Gate charge total (4.5 V)	V _{S1S2} = 6 V, I _S = 5 A		8.4	10.9	nC
Q _{gd}	Gate charge gate-to-drain			1.9		nC
Q _{gs}	Gate charge gate-to-source			2.2		nC
Q _{g(th)}	Gate charge at V _{th}			0.6		nC
Q _{oss}	Output charge	V _{S1S2} = 6 V, V _{GS} = 0 V		2.9		nC
t _{d(on)}	Turnon delay time	V _{S1S2} = 6 V, V _{GS} = 4.5 V, I _{S1S2} = 5 A, R _G = 0 Ω		205		ns
t _r	Rise time			353		ns
t _{d(off)}	Turnoff delay time			711		ns
t _f	Fall time			589		ns
DIODE CHARACTERISTICS						
V _{F(S-S)}	Source-to-source diode forward voltage	I _{SS} = 5 A, V _{G1S1} = 0 V, V _{G2S2} = 4.5 V		0.79	1.0	V

(1) Dynamic characteristics values specified are per single FET.

5.2 Thermal Information

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

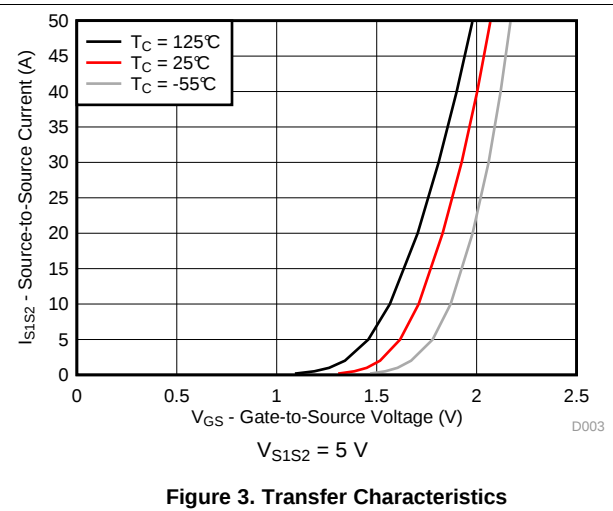
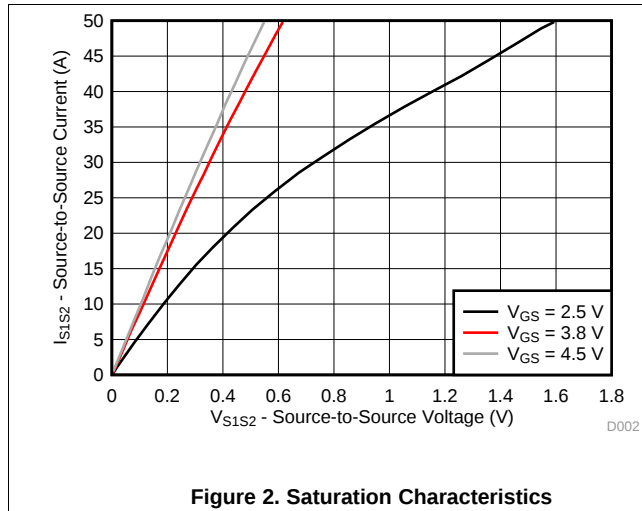
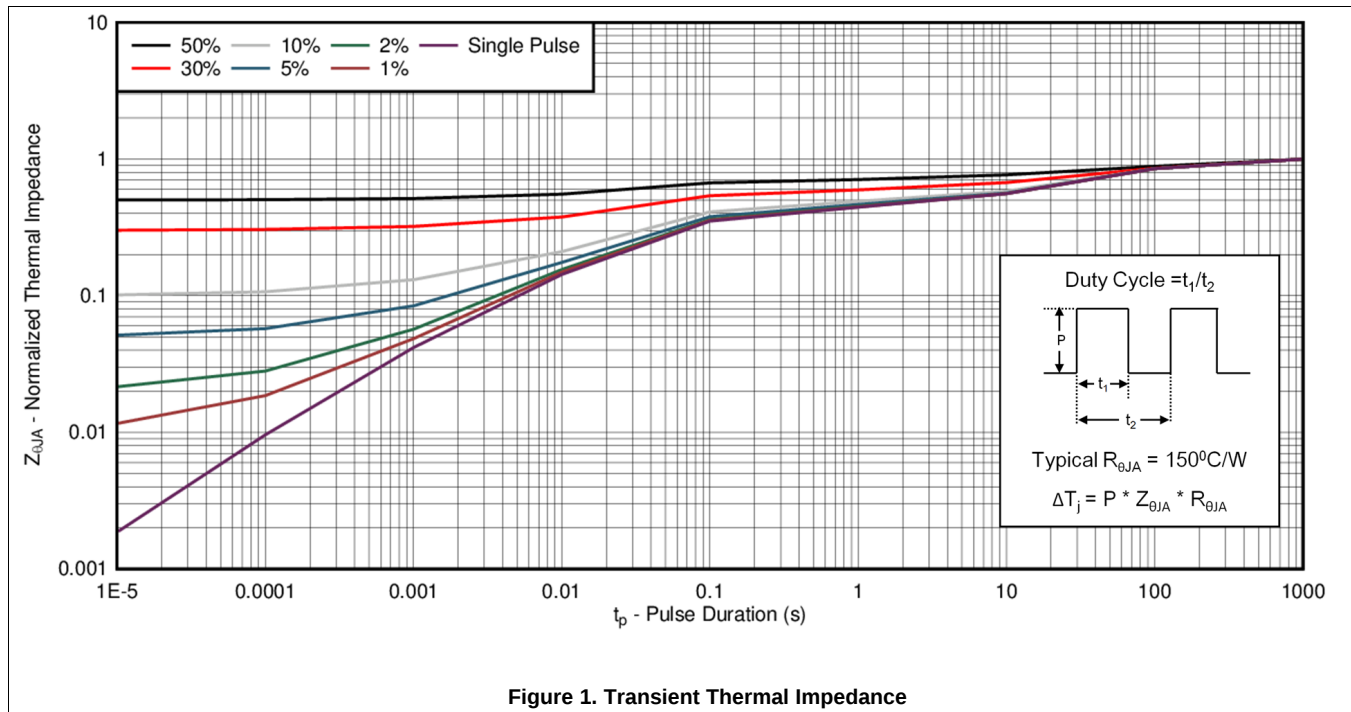
THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾		150		$^\circ\text{C/W}$
	Junction-to-ambient thermal resistance ⁽²⁾		55		

(1) Device mounted on FR4 material with minimum Cu mounting area.

(2) Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.

5.3 Typical MOSFET Characteristics

$T_A = 25^\circ\text{C}$ (unless otherwise stated)



Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

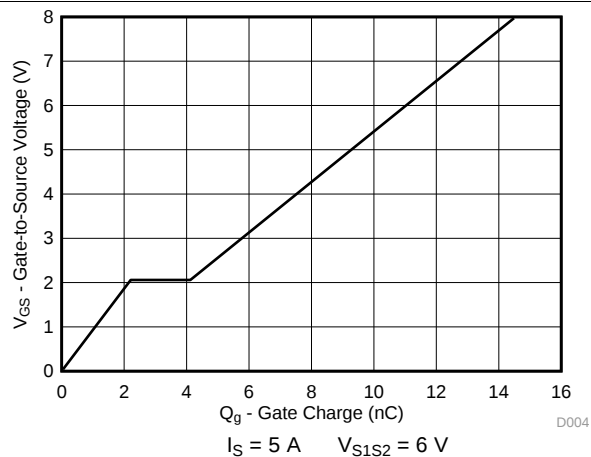


Figure 4. Gate Charge

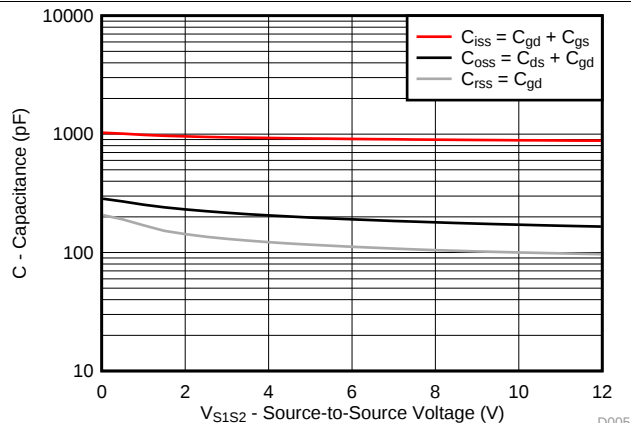


Figure 5. Capacitance

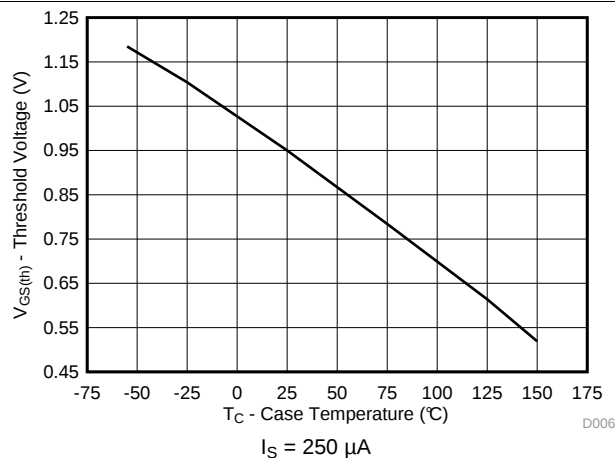


Figure 6. Threshold Voltage vs Temperature

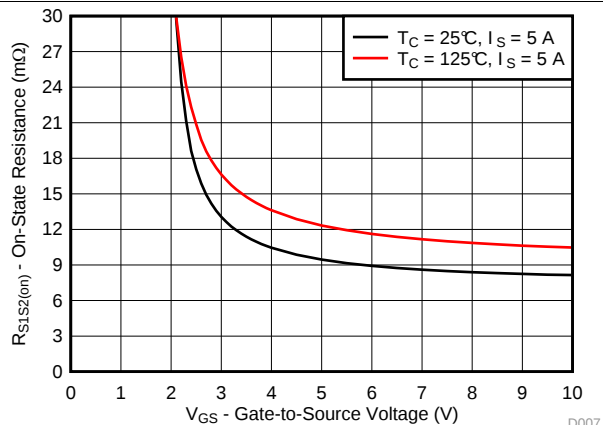


Figure 7. On-State Source-to-Source Resistance vs Gate-to-Source Voltage

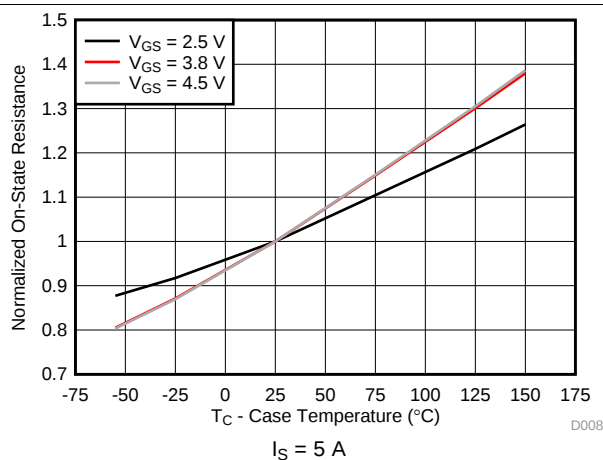


Figure 8. Normalized On-State Resistance vs Temperature

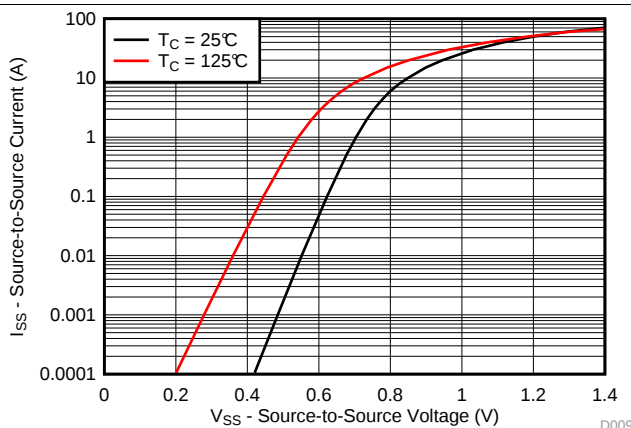
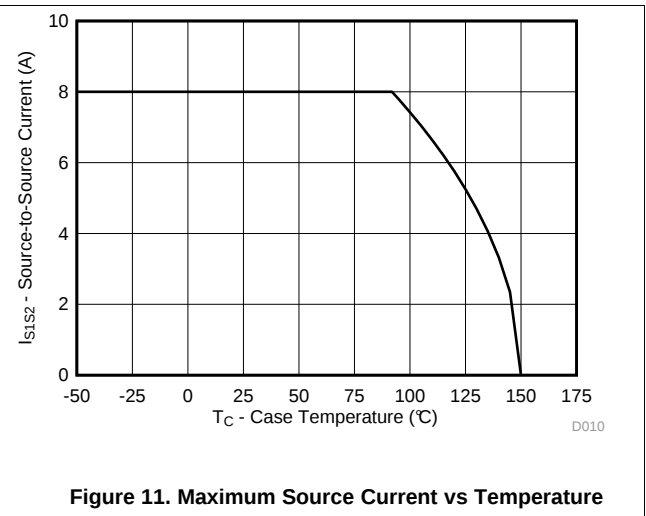
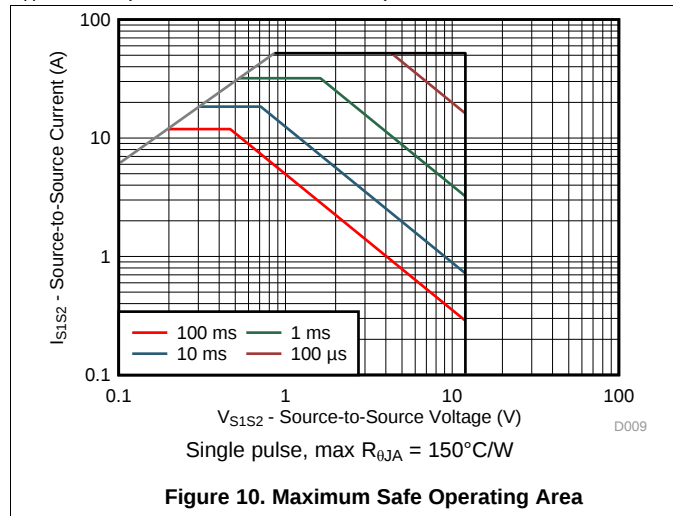


Figure 9. Typical Diode Forward Voltage

Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)



6 器件和文档支持

6.1 接收文档更新通知

要接收文档更新通知，请导航至 TI.com 上的器件产品文件夹。请单击右上角的通知我 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

6.2 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

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设计支持 [TI 参考设计支持](#) 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

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6.4 静电放电警告

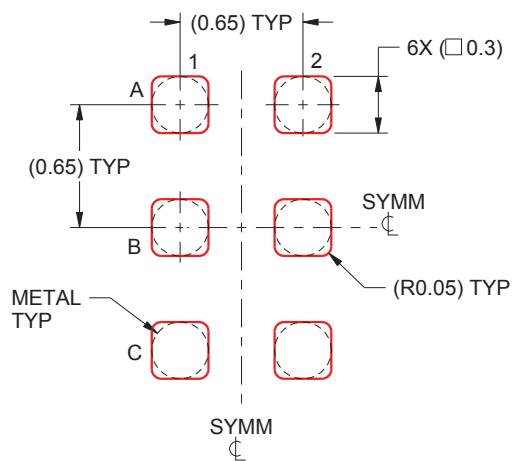
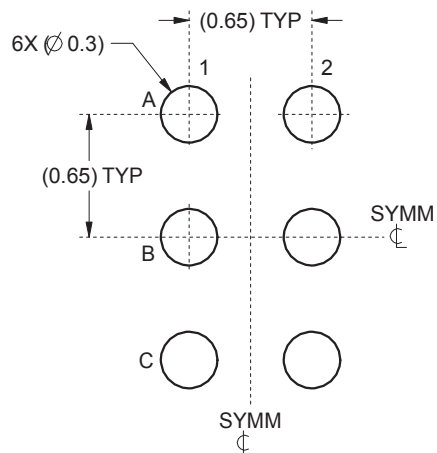


这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

6.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD83325L	ACTIVE	PICOSTAR	YJE	6	3000	RoHS & Green	Call TI	Level-1-260C-UNLIM		83325L	Samples
CSD83325LT	ACTIVE	PICOSTAR	YJE	6	250	RoHS & Green	Call TI	Level-1-260C-UNLIM	-55 to 150	83325L	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD83325L	PICOST AR	YJE	6	3000	178.0	8.4	1.25	2.34	0.32	4.0	8.0	Q1
CSD83325LT	PICOST AR	YJE	6	250	178.0	8.4	1.25	2.34	0.32	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD83325L	PICOSTAR	YJE	6	3000	220.0	220.0	35.0
CSD83325LT	PICOSTAR	YJE	6	250	220.0	220.0	35.0

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